

# S-25A010A/020A/040A

# FOR AUTOMOTIVE 125°C OPERATION SPI SERIAL E<sup>2</sup>PROM

www.ablicinc.com

© ABLIC Inc., 2008-2014 Rev.5.2 02

This IC is a SPI serial E<sup>2</sup>PROM which operates under the high temperature, at high speed, with the wide range operation for automotive components. This IC has the capacity of 1 K-bit, 2 K-bit, 4 K-bit and the organization of 128 words × 8-bit, 256 words  $\times$  8-bit, 512 words  $\times$  8-bit. Page write and Sequential read are available.

Before using the product in automobile control unit or medical equipment, contact to ABLIC Inc. is indispensable.

#### ■ Features ■ Packages

· Operating voltage range Read: 2.5 V to 5.5 V

Write: 2.5 V to 5.5 V Operation frequency: 6.5 MHz max. · Write time: 4.0 ms max.

• SPI mode (0, 0) and (1, 1)

· Page write: 16 bytes / page

· Sequential read

Write protect: Software. Hardware  $(5.0 \times 6.0 \times t1.75 \text{ mm})$ 

25%, 50%, 100% Protect area:

Monitoring of a write memory state by the status register

 Function to prevent malfunction by monitoring clock pulse 8-Pin TSSOP

· Write protect function during the low power supply voltage

• CMOS schmitt input ( CS , SCK, SI, WP , HOLD )

 $10^6 \text{ cycle / word}^{*2} \text{ (Ta = +25°C)}$ Endurance<sup>\*1</sup>:

 $5 \times 10^5$  cycle / word\*2 (Ta = +125°C)

100 years (Ta =  $+25^{\circ}$ C) · Data retention:

50 years (Ta =  $+125^{\circ}$ C)

· Memory capacity

S-25A010A: 1 K-bit S-25A020A: 2 K-bit 4 K-bit S-25A040A:

• Initial delivery state: FFh, BP1 = 0, BP0 = 0Wafer level burn-in Burn-in specification: Operation temperature range: Ta = -40°C to +125°C

Lead-free (Sn 100%), halogen-free\*3

AEC-Q100 qualified\*4

 $(2.9 \times 4.0 \times t0.8 \text{ mm})$ \*1. Refer to "■ Endurance" for details.

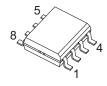
\*2. For each address (Word: 8-bit)

Refer to "■ Product Name Structure" for details.

\*4. Contact our sales office for details.

Remark Refer to "3. Product name list" in "■ Product Name Structure" for details of package and product.

• 8-Pin SOP (JEDEC)





 $(3.0 \times 6.4 \times t1.1 \text{ mm})$ 

TMSOP-8



# **■** Block Diagram

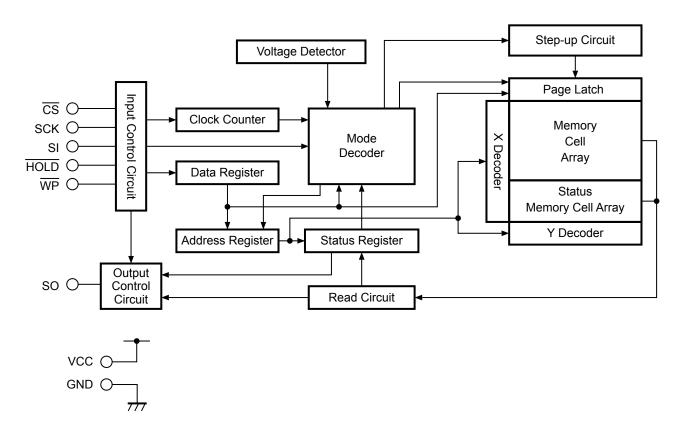


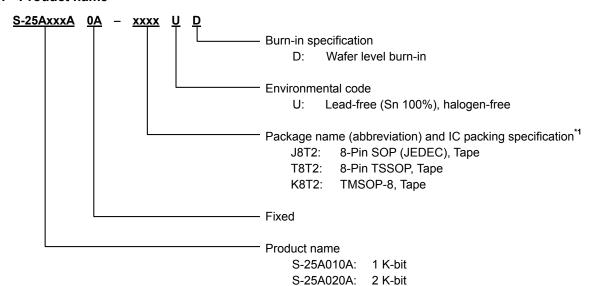
Figure 1

## ■ AEC-Q100 Qualified

This IC supports AEC-Q100 for operation temperature grade 1. Contact our sales office for details of AEC-Q100 reliability specification.

## **■ Product Name Structure**

## 1. Product name



S-25A020A: 2 K-bit S-25A040A: 4 K-bit

\*1. Refer to the tape drawing.

### 2. Packages

Table 1 Package Drawing Codes

	Take to a desired a second a s									
Package Name Dimension		Tape	Reel							
8-Pin SOP (JEDEC)	FJ008-A-P-SD	FJ008-D-C-SD	FJ008-D-R-SD							
8-Pin TSSOP	FT008-A-P-SD	FT008-E-C-SD	FT008-E-R-SD							
TMSOP-8	FM008-A-P-SD	FM008-A-C-SD	FM008-A-R-SD							

#### 3. Product name list

Table 2

Product Name	Capacity	Package	Quantity
S-25A010A0A-J8T2UD	1 K bit	8-Pin SOP (JEDEC)	2000 pcs / reel
S-25A010A0A-T8T2UD	1 K bit	8-Pin TSSOP	3000 pcs / reel
S-25A010A0A-K8T2UD	1 K bit	TMSOP-8	4000 pcs / reel
S-25A020A0A-J8T2UD	2 K bit	8-Pin SOP (JEDEC)	2000 pcs / reel
S-25A020A0A-T8T2UD	2 K bit	8-Pin TSSOP	3000 pcs / reel
S-25A020A0A-K8T2UD	2 K bit	TMSOP-8	4000 pcs / reel
S-25A040A0A-J8T2UD	4 K bit	8-Pin SOP (JEDEC)	2000 pcs / reel
S-25A040A0A-T8T2UD	4 K bit	8-Pin TSSOP	3000 pcs / reel
S-25A040A0A-K8T2UD	4 K bit	TMSOP-8	4000 pcs / reel

**Remark** 1. Please contact our sales office for products with product name structure other than those specified above.

2. This IC is wafer level burn-in specification.

# **■** Pin Configurations

# 1. 8-Pin SOP (JEDEC)

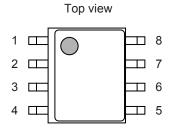


Figure 2

Table 3

Pin No.	Symbol	Description
1	CS*1	Chip select input
2	SO	Serial data output
3	WP *1	Write protect input
4	GND	Ground
5	SI <sup>*1</sup>	Serial data input
6	SCK*1	Serial clock input
7	HOLD *1	Hold input
8	VCC	Power supply

## 2. 8-Pin TSSOP

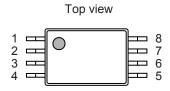


Figure 3

# Table 4

Pin No.	Symbol	Description
1	CS*1	Chip select input
2	SO	Serial data output
3	₩P *1	Write protect input
4	GND	Ground
5	SI <sup>*1</sup>	Serial data input
6	SCK*1	Serial clock input
7	HOLD *1	Hold input
8	VCC	Power supply

# 3. TMSOP-8

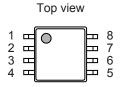


Figure 4

Table 5

Pin No.	Symbol	Description
1	<del>CS</del> *¹	Chip select input
2	SO	Serial data output
3	WP *1	Write protect input
4	GND	Ground
5	SI <sup>*1</sup>	Serial data input
6	SCK <sup>*1</sup>	Serial clock input
7	HOLD *1	Hold input
8	VCC	Power supply

\*1. Do not use it in "High-Z".

# ■ Absolute Maximum Ratings

## Table 6

Item	Symbol	Absolute Maximum Rating	Unit
Power supply voltage	$V_{CC}$	−0.3 to +7.0	V
Input voltage	$V_{IN}$	−0.3 to +7.0	V
Output voltage	$V_{OUT}$	$-0.3$ to $V_{CC} + 0.3$	<b>&gt;</b>
Operation ambient temperature	$T_{opr}$	-40 to +125	°C
Storage temperature	T <sub>stq</sub>	−65 to +150	°C

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

# **■** Recommended Operating Conditions

Table 7

Itom	Cumbal	Condition	Ta = -40°C	Unit		
Item	Symbol	Condition	Min.	Max.	Offic	
Power supply voltage	V	Read	2.5	5.5	V	
	$V_{CC}$	Write	2.5	5.5	V	
High level input voltage	V <sub>IH</sub>	V <sub>CC</sub> = 2.5 V to 5.5 V	$0.7 \times V_{CC}$	V <sub>CC</sub> + 1.0	V	
Low level input voltage	V <sub>IL</sub>	$V_{CC} = 2.5 \text{ V to } 5.5 \text{ V}$	-0.3	$0.3 \times V_{CC}$	V	

# **■** Pin Capacitance

Table 8

 $(Ta = +25^{\circ}C. f = 1.0 MHz. V_{CC} = 5.0 V)$ 

			(1a - +25 O,	1 - 1.0 WII IZ, V	<u>cc - 3.0 v</u>
Item	Symbol	Condition	Min.	Max.	Unit
Input capacitance	C <sub>IN</sub>	V <sub>IN</sub> = 0 V ( $\overline{\text{CS}}$ , SCK, SI, $\overline{\text{WP}}$ , $\overline{\text{HOLD}}$ )	_	8	pF
Output capacitance	C <sub>OUT</sub>	V <sub>OUT</sub> = 0 V (SO)	_	10	pF

# **■** Endurance

### Table9

Item	Symbol	Operation Ambient Temperature	Min.	Max.	Unit
Endurance N	N <sub>W</sub>	Ta = -40°C to +85°C	10 <sup>6</sup>	_	cycle / word*1
		Ta = -40°C to +105°C	8 × 10 <sup>5</sup>	ı	cycle / word*1
		Ta = -40°C to +125°C	5 × 10 <sup>5</sup>	-	cycle / word*1

<sup>\*1.</sup> For each address (Word: 8-bit)

# **■** Data Retention

Table 10

Item	Symbol	Operation Ambient Temperature	Min.	Max.	Unit
Data retention	_	Ta = +25°C	100	_	year
	_	Ta = -40°C to +125°C	50	_	year

# **■ DC Electrical Characteristics**

# Table 11

Item Symbol			$Ta = -40^{\circ}C \text{ to } +125^{\circ}C$						
	Cumbal	Condition	V <sub>CC</sub> = 2.5 \	/ to 3.0 V	$V_{CC} = 3.0$	V to 4.5 V	$V_{CC} = 4.5$	V to 5.5 V	Unit
	Syllibol		f <sub>SCK</sub> = 3.5 MHz		$f_{SCK} = 5.0 \text{ MHz}$		$f_{SCK} = 6.5 \text{ MHz}$		Offic
			Min.	Max.	Min.	Max.	Min.	Max.	
Current consumption (read)	I <sub>CC1</sub>	No load at SO pin	ı	1.5	ı	2.0	ı	2.5	mA

## Table 12

ltom Su			Ta = -40°C to +125°C						
	Cumbal	Condition	$V_{CC} = 2.5 V$	/ to 3.0 V	$V_{CC} = 3.0$	V to 4.5 V	$V_{CC} = 4.5$	V to 5.5 V	Unit
Item Symbol		Condition	$f_{SCK}$ = 3.5 MHz		$f_{SCK} = 5.0 \text{ MHz}$		f <sub>SCK</sub> = 6.5 MHz		OHIL
			Min.	Max.	Min.	Max.	Min.	Max.	
Current consumption (write)	I <sub>CC2</sub>	No load at SO pin	_	2.0	_	2.5	_	3.0	mA

## Table 13

			Ta = -40°C to +85°C Ta = +85°C to +125°C								
Item	Symbol	Condition	$V_{CC} = 2.5$	V to 4.5 V	$V_{CC} = 4.5$	V to 5.5 V	$V_{CC} = 2.5$	V to 4.5 V	$V_{CC} = 4.5$	V to 5.5 V	Unit
			Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Standby current consumption	I <sub>SB</sub>	$\overline{\text{CS}} = \text{V}_{\text{CC}},$ $\text{SO} = \text{Open}$ Other inputs are $\text{V}_{\text{CC}}$ or GND	ı	2.0	I	3.0	ı	8.0	_	10.0	μА
Input leakage current	ILI	$V_{IN}$ = GND to $V_{CC}$	_	1.0	ı	1.0	1	2.0	_	2.0	μА
Output leakage current	I <sub>LO</sub>	$V_{OUT}$ = GND to $V_{CC}$	_	1.0	ı	1.0	1	2.0	_	2.0	μА
Low level	$V_{OL1}$	I <sub>OL</sub> = 2.0 mA	_	1	1	0.4	_	1	_	0.4	V
output voltage	$V_{OL2}$	I <sub>OL</sub> = 1.5 mA	_	0.4	_	0.4	_	0.4	_	0.4	V
High level	V <sub>OH1</sub>	I <sub>OH</sub> = -2.0 mA	_	_	$0.8 \times V_{CC}$	_	_	_	0.8 × V <sub>CC</sub>	_	V
output voltage	V <sub>OH2</sub>	I <sub>OH</sub> = -0.4 mA	0.8 × V <sub>CC</sub>	_	0.8 × V <sub>CC</sub>	_	0.8 × V <sub>CC</sub>	_	0.8 × V <sub>CC</sub>	_	٧

# ■ AC Electrical Characteristics

**Table 14 Measurement Conditions** 

Input pulse voltage	$0.2 \times V_{CC}$ to $0.8 \times V_{CC}$
Output reference voltage	$0.5 \times V_{CC}$
Output load	100 pF

Table 15

Table 15  Ta = -40°C to +125°C								
Item		V <sub>CC</sub> = 2.5	/ to 5.5 V	V <sub>CC</sub> = 3.0 \	/ to 5.5 V	V <sub>CC</sub> = 4.5	V to 5.5 V	Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
SCK clock frequency	f <sub>SCK</sub>	_	3.5	_	5.0	_	6.5	MHz
CS setup time during CS falling	t <sub>CSS.CL</sub>	90	_	90	_	65	_	ns
CS setup time during CS rising	t <sub>CSS.CH</sub>	90	_	90	-	65	_	ns
CS deselect time	t <sub>CDS</sub>	160	_	140	1	110	_	ns
CS hold time during CS falling	t <sub>CSH.CL</sub>	90	_	90	-	65	_	ns
CS hold time during CS rising	t <sub>CSH.CH</sub>	90	_	90	_	65	_	ns
SCK clock time "H"*1	t <sub>HIGH</sub>	125	_	95	I	65	_	ns
SCK clock time "L"*1	$t_{LOW}$	125	_	95	ı	65	_	ns
Rising time of SCK clock*2	t <sub>RSK</sub>	_	1	_	1	1	1	μS
Falling time of SCK clock*2	t <sub>FSK</sub>	_	1	_	1	_	1	μS
SI data input setup time	t <sub>DS</sub>	20		20	_	20	_	ns
SI data input hold time	$t_{DH}$	30		30	_	30	_	ns
SCK "L" hold time during HOLD rising	t <sub>SKH.HH</sub>	70	_	70	-	45	_	ns
SCK "L" hold time during HOLD falling	t <sub>SKH.HL</sub>	40	_	40	-	30	_	ns
SCK "L" setup time during HOLD falling	t <sub>SKS.HL</sub>	0	_	0	_	0	_	ns
SCK "L" setup time during HOLD rising	t <sub>SKS.HH</sub>	0	_	0	-	0	_	ns
Disable time of SO output*2	t <sub>OZ</sub>	_	100	_	100	_	75	ns
Delay time of SO output	t <sub>OD</sub>	_	120	_	90	_	60	ns
Hold time of SO output	t <sub>OH</sub>	0		0	_	0	_	ns
Rising time of SO output*2	t <sub>RO</sub>	_	80	_	80	_	50	ns
Falling time of SO output*2	$t_{FO}$	_	80	_	80	_	50	ns
Disable time of SO output during HOLD falling*2	t <sub>OZ.HL</sub>	_	100	_	100	_	75	ns
Delay time of SO output during HOLD rising*2	t <sub>OD.HH</sub>	_	80	_	80	_	60	ns
WP setup time	t <sub>WS1</sub>	0	_	0	_	0	_	ns
WP hold time	t <sub>WH1</sub>	0	_	0		0	_	ns
WP release / setup time	t <sub>WS2</sub>	0	_	0	_	0	_	ns
WP release / hold time	t <sub>WH2</sub>	150		150	_	100	_	ns

<sup>\*1.</sup> The clock cycle of the SCK clock (frequency  $f_{SCK}$ ) is 1 /  $f_{SCK}$   $\mu s$ . This clock cycle is determined by a combination of several AC characteristics. Note that the clock cycle cannot be set as (1 /  $f_{SCK}$ ) =  $t_{LOW}$  (min.) +  $t_{HIGH}$  (min.) by minimizing the SCK clock cycle time.

**<sup>\*2.</sup>** These are values of sample and not 100% tested.

Table 16

Table 16  Ta = -40°C to +105°C								
Item		V <sub>CC</sub> = 2.5 \	V to 5.5 V	V <sub>CC</sub> = 3.0 \	/ to 5.5 V	V <sub>CC</sub> = 4.5	V to 5.5 V	Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
SCK clock frequency	f <sub>SCK</sub>	_	3.5	_	5.0	_	6.5	MHz
CS setup time during CS falling	t <sub>CSS.CL</sub>	90	-	90	-	65	_	ns
CS setup time during CS rising	t <sub>CSS.CH</sub>	90	-	90	-	65	_	ns
CS deselect time	t <sub>CDS</sub>	160	-	140	-	110	_	ns
CS hold time during CS falling	t <sub>CSH.CL</sub>	90	ı	90	1	65	_	ns
CS hold time during CS rising	t <sub>CSH.CH</sub>	90	1	90	1	65	_	ns
SCK clock time "H"*1	t <sub>HIGH</sub>	125	_	95	_	65	_	ns
SCK clock time "L" <sup>*1</sup>	$t_{LOW}$	125	_	95	_	65	_	ns
Rising time of SCK clock*2	t <sub>RSK</sub>	_	1	_	1	_	1	μS
Falling time of SCK clock*2	t <sub>FSK</sub>	_	1	_	1	_	1	μS
SI data input setup time	$t_{DS}$	20	-	20	-	20	_	ns
SI data input hold time	$t_{DH}$	30	-	30	-	30	_	ns
SCK "L" hold time during HOLD rising	t <sub>SKH.HH</sub>	70	_	70	_	45	_	ns
SCK "L" hold time during HOLD falling	t <sub>SKH.HL</sub>	40	_	40	_	30	_	ns
SCK "L" setup time during HOLD falling	t <sub>SKS.HL</sub>	0	_	0	-	0	_	ns
SCK "L" setup time during HOLD rising	t <sub>SKS.HH</sub>	0	_	0	_	0	_	ns
Disable time of SO output*2	t <sub>OZ</sub>	_	100	_	100	_	75	ns
Delay time of SO output	$t_{OD}$	_	120	_	90	_	60	ns
Hold time of SO output	t <sub>OH</sub>	0	_	0	_	0	_	ns
Rising time of SO output*2	t <sub>RO</sub>	_	80	_	70	_	50	ns
Falling time of SO output*2	t <sub>FO</sub>	_	80	_	70	_	50	ns
Disable time of SO output during HOLD falling*2	t <sub>OZ.HL</sub>	_	100	_	100	_	75	ns
Delay time of SO output during HOLD rising*2	t <sub>OD.HH</sub>	_	80	_	80	_	60	ns
WP setup time	t <sub>WS1</sub>	0	_	0	_	0	_	ns
WP hold time	t <sub>WH1</sub>	0	_	0	_	0	_	ns
WP release / setup time	t <sub>WS2</sub>	0	_	0	_	0	_	ns
WP release / hold time	t <sub>WH2</sub>	150	_	150	-	100	_	ns

<sup>\*1.</sup> The clock cycle of the SCK clock (frequency  $f_{SCK}$ ) is 1 /  $f_{SCK}$   $\mu s$ . This clock cycle is determined by a combination of several AC characteristics. Note that the clock cycle cannot be set as (1 /  $f_{SCK}$ ) =  $t_{LOW}$  (min.) +  $t_{HIGH}$  (min.) by minimizing the SCK clock cycle time.

<sup>\*2.</sup> These are values of sample and not 100% tested.

Table 17

			7	Га = –40°C	to +85°C			
Item		V <sub>CC</sub> = 2.5 \	V to 5.5 V	V <sub>CC</sub> = 3.0 \	/ to 5.5 V	V <sub>CC</sub> = 4.5	V to 5.5 V	Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
SCK clock frequency	f <sub>SCK</sub>	_	4.0	_	5.0	-	7.0	MHz
CS setup time during CS falling	t <sub>CSS.CL</sub>	90	_	80	_	60	_	ns
CS setup time during CS rising	t <sub>CSS.CH</sub>	90	-	80	-	60	_	ns
CS deselect time	t <sub>CDS</sub>	150	1	120	-	100	_	ns
CS hold time during CS falling	t <sub>CSH.CL</sub>	90	1	80	1	60	_	ns
CS hold time during CS rising	t <sub>CSH.CH</sub>	90	-	80	-	60	_	ns
SCK clock time "H"*1	t <sub>HIGH</sub>	115	I	90	ı	60	_	ns
SCK clock time "L"*1	$t_{LOW}$	115	I	90	ı	60	_	ns
Rising time of SCK clock*2	t <sub>RSK</sub>	_	1	_	1	_	1	μS
Falling time of SCK clock*2	t <sub>FSK</sub>	_	1	_	1	_	1	μS
SI data input setup time	t <sub>DS</sub>	20	_	20	_	20	_	ns
SI data input hold time	$t_{DH}$	30	_	30	_	30	_	ns
SCK "L" hold time during HOLD rising	t <sub>SKH.HH</sub>	70	-	60	-	40	_	ns
SCK "L" hold time during HOLD falling	t <sub>SKH.HL</sub>	40	-	40	-	30	_	ns
SCK "L" setup time during HOLD falling	t <sub>SKS.HL</sub>	0	_	0	_	0	_	ns
SCK "L" setup time during HOLD rising	t <sub>SKS.HH</sub>	0	1	0	-	0	_	ns
Disable time of SO output*2	$t_{OZ}$	_	100	_	100	_	70	ns
Delay time of SO output	t <sub>OD</sub>	_	110	_	85	_	55	ns
Hold time of SO output	t <sub>OH</sub>	0	_	0	_	0	_	ns
Rising time of SO output*2	$t_{RO}$	_	80	_	50	_	40	ns
Falling time of SO output*2	$t_{FO}$	_	80	_	50	-	40	ns
Disable time of SO output during HOLD falling*2	t <sub>OZ.HL</sub>	_	100	_	100	_	70	ns
Delay time of SO output during HOLD rising*2	t <sub>OD.HH</sub>	_	80	_	75	_	55	ns
WP setup time	t <sub>WS1</sub>	0	_	0	_	0	_	ns
WP hold time	t <sub>WH1</sub>	0	_	0	_	0	_	ns
WP release / setup time	t <sub>WS2</sub>	0	_	0	_	0	_	ns
WP release / hold time	t <sub>WH2</sub>	150	_	150	_	100	_	ns

<sup>\*1.</sup> The clock cycle of the SCK clock (frequency  $f_{SCK}$ ) is 1 /  $f_{SCK}$   $\mu s$ . This clock cycle is determined by a combination of several AC characteristics. Note that the clock cycle cannot be set as (1 /  $f_{SCK}$ ) =  $t_{LOW}$  (min.) +  $t_{HIGH}$  (min.) by minimizing the SCK clock cycle time.

<sup>\*2.</sup> These are values of sample and not 100% tested.

Table 18

		Ta = -40°C		
Item	Symbol	$V_{CC} = 2.5$	Unit	
		Min.	Max.	
Write time	t <sub>PR</sub>	1	4.0	ms

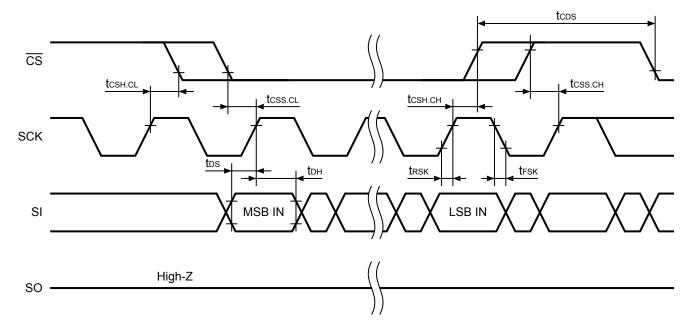


Figure 5 Serial Input Timing

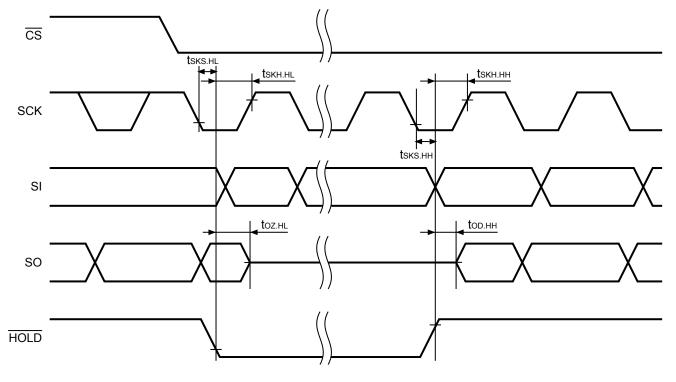


Figure 6 Hold Timing

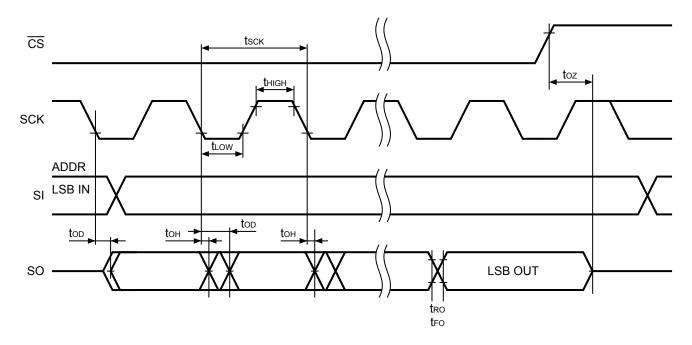


Figure 7 Serial Output Timing

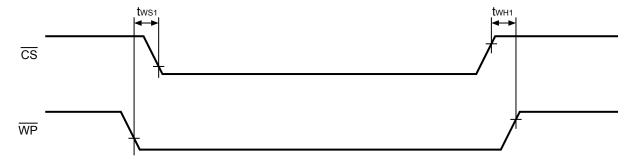


Figure 8 Valid Timing in Write Protect

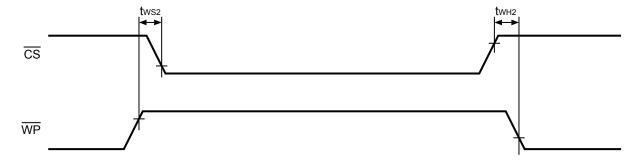


Figure 9 Invalid Timing in Write Protect

#### ■ Pin Functions

# 1. CS (chip select input) pin

This is an input pin to set a chip in the select status. In the "H" input level, this IC is in the non-select status and its output is "High-Z". This IC is in standby as long as it is not in write inside. This IC goes in active by setting the chip select to "L". Input any instruction code after power-on and a falling of chip select.

## 2. SI (serial data input) pin

This pin is to input serial data. This pin receives an instruction code, an address and write data. This pin latches data at rising edge of serial clock.

## 3. SO (serial data output) pin

This pin is to output serial data. The data output changes at falling edge of serial clock.

### 4. SCK (serial clock input) pin

This is a clock input pin to set the timing of serial data. An instruction code, an address and write data are received at a rising edge of clock. Data is output during falling edge of clock.

# 5. WP (write protect input) pin

This is an input pin to protect memory data when write instruction (WRITE, WRSR) is being input. By setting this pin to "L", the WEL bit in the status register is set to "L". Therefore this IC does not write to the  $E^2PROM$ , however, it accepts other instructions. Fix this pin "H" or "L" not to set it in the floating state.

Refer to "■ Protect Operation" for details.

## 6. HOLD (hold input) pin

This pin is used to pause serial communications without setting this IC in the non-select status.

In the hold status, the serial output goes in "High-Z", the serial input and the serial clock go in "Don't care". During the hold operation, be sure to set this IC in active by setting the chip select  $(\overline{CS})$  pin to "L".

Refer to "■ Hold Operation" for details.

# ■ Initial Delivery State

Initial delivery state of all addresses is "FFh".

Moreover, initial delivery state of the status register nonvolatile memory is as follows.

- BP1 = 0
- BP0 = 0

## ■ Instruction Sets

**Table 19** and **Table 20** are the list of instruction for this IC. The instruction is able to be input by changing the  $\overline{CS}$  "H" to "L". Input the instruction in the MSB first. Each instruction code is organized with 1-byte as shown below. If this IC receives any invalid instruction code, this IC goes in the non-select status.

#### 1. S-25A010A/020A

Table 19 Instruction Set

		Instruction Code	Address	Data
Instruction	Operation	SCK Input Clock	SCK Input Clock	SCK Input Clock
		1 to 8	9 to 16	17 to 24
WREN	Write enable	0000 X110	ı	_
WRDI	Write disable	0000 X100	ı	-
RDSR	Read the status register	0000 X101	b7 to b0 output*1	-
WRSR	Write in the status register	0000 X001	b7 to b0 input	_
READ	Read memory data	0000 X011	A7 <sup>*2</sup> to A0	D7 to D0 output*3
WRITE	Write memory data	0000 X010	A7 <sup>*2</sup> to A0	D7 to D0 input

**<sup>\*1.</sup>** Sequential data reading is possible.

Remark X = Don't care.

#### 2. S-25A040A

Table 20 Instruction Set

		Instruction Code	Address	Data
Instruction	Operation	SCK Input Clock	SCK Input Clock	SCK Input Clock
		1 to 8	9 to 16	17 to 24
WREN	Write enable	0000 X110	_	_
WRDI	Write disable	0000 X100	_	_
RDSR	Read the status register	0000 X101	b7 to b0 output*1	_
WRSR	Write in the status register	0000 X001	b7 to b0 input	_
READ	Read memory data	0000 [A8 <sup>*2</sup> ]011	A7 to A0	D7 to D0 output*3
WRITE	Write memory data	0000 [A8 <sup>*2</sup> ]010	A7 to A0	D7 to D0 input

**<sup>\*1.</sup>** Sequential data reading is possible.

<sup>\*2.</sup> In the S-25A010A, A7 = Don't care because the address range is A6 to A0.

<sup>\*3.</sup> After outputting data in the specified address, data in the following address is output.

<sup>\*2.</sup> In the S-25A040A, assign bit A8 in the address into the fifth bit in an instruction code.

**<sup>\*3.</sup>** After outputting data in the specified address, data in the following address is output.

# Operation

# 1. Status register

The status register's organization is below. The status register can write and read by a specific instruction.

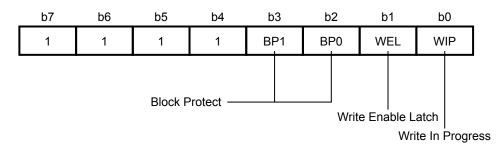


Figure 10 Organization of Status Register

The status / control bits of the status register are as follows.

# 1. 1 BP1, BP0 (b3, b2) : Block Protect

Bit BP1 and BP0 are composed of the nonvolatile memory. The area size of Software Protect with respect to WRITE instructions is defined by the BP1 and BP0 bits. Rewriting these bits is possible by the WRSR instruction. To protect the memory area against the WRITE instruction, set either or both of bit BP1 and BP0 to "1". Rewriting bit BP1 and BP0 is possible unless they are in Hardware Protect mode. Refer to "**Protect Operation**" for details of Block Protect.

## 1. 2 WEL (b1): Write Enable Latch

Bit WEL shows the status of internal Write Enable Latch. Bit WEL is set by the WREN instruction only. If bit WEL is "1", this is the status that Write Enable Latch is set. If bit WEL is "0", Write Enable Latch is in reset, so that this IC does not receive the WRITE or WRSR instruction. Bit WEL is reset after these operations;

- The power supply voltage is dropping
- At power-on
- After performing WRDI
- After the completion of write operation by the WRSR instruction
- After the completion of write operation by the WRITE instruction
- After setting WP pin to "L"

#### 1. 3 WIP (b0): Write In Progress

Bit WIP is a read only bit. It indicates whether the internal memory is in the write operation or not by the WRITE or WRSR instruction. Bit WIP is "1" during the write operation but "0" during any other status. **Figure 11** shows the usage example.

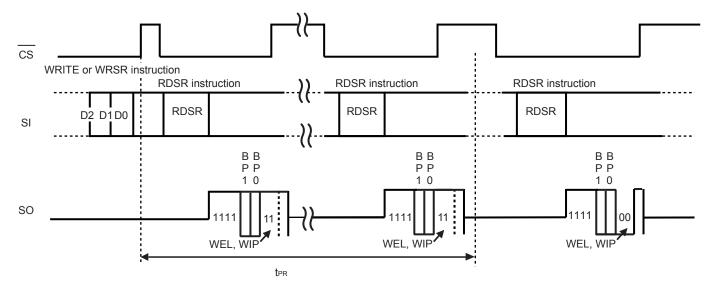


Figure 11 Usage Example of WEL, WIP Bits during Write

## 2. Write enable (WREN)

Before writing data (WRITE and WRSR), be sure to set bit Write Enable Latch (WEL). This instruction is to set bit WEL. Its operation is below.

After selecting this IC by the chip select ( $\overline{CS}$ ), input the instruction code from serial data input (SI). To set bit WEL, set this IC in the non-select status by  $\overline{CS}$  at the 8th clock of the serial clock (SCK). To cancel the WREN instruction, input the clock different from a specified value (n = 8 clock) while  $\overline{CS}$  is in "L".

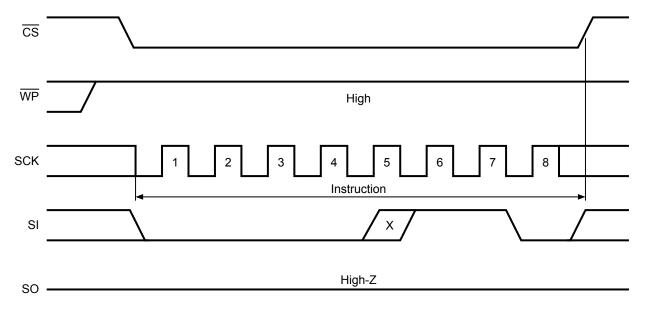


Figure 12 WREN Operation

## 3. Write disable (WRDI)

The WRDI instruction is one of ways to reset bit Write Enable Latch (WEL). After selecting this IC by the chip select  $(\overline{CS})$ , input the instruction code from serial data input (SI).

To reset bit WEL, set this IC in the non-select status by  $\overline{\text{CS}}$  at the 8th clock of the serial clock.

To cancel the WRDI instruction, input the clock different from a specified value (n = 8 clock) while  $\overline{CS}$  is in "L". Bit WEL is reset after the operations shown below.

- · The power supply voltage is dropping
- At power-on
- After performing WRDI
- After the completion of write operation by the WRSR instruction
- After the completion of write operation by the WRITE instruction
- After setting WP pin to "L"

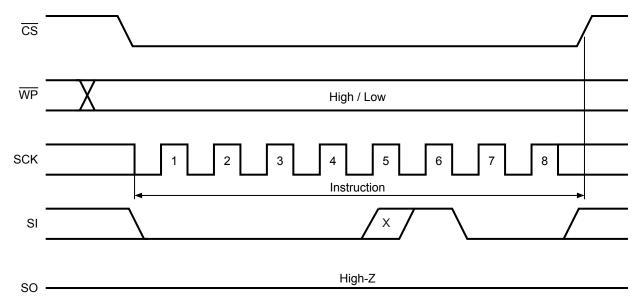


Figure 13 WRDI Operation

# 4. Read the status register (RDSR)

Reading data in the status register is possible by the RDSR instruction. During the write operation, it is possible to confirm the progress by checking bit WIP.

Set the chip select ( $\overline{CS}$ ) "L" first. After that, input the instruction code from serial data input (SI). The status of bit in the status register is output from serial data output (SO). Sequential read is available for the status register. To stop the read cycle, set  $\overline{CS}$  to "H".

It is possible to read the status register always. The bits in it are valid and can be read by RDSR even in the write cycle.

The 2 bits WEL and WIP are updated during the write cycle. The updated nonvolatile bits BP1 and BP0 can be acquired by performing a new RDSR instruction after verifying the completion of the write cycle.

b7, b6, b5, and b4 are "1" when they are read by the RDSR instruction.

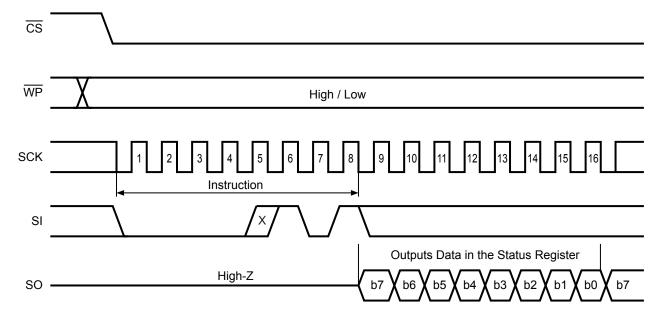


Figure 14 RDSR Operation

### 5. Write in the status register (WRSR)

The values of status register (BP1, BP0) can be rewritten by inputting the WRSR instruction. But b7, b6, b5, b4, b1, b0 of status register cannot be rewritten. b7 to b4 are always "1" when reading the status register.

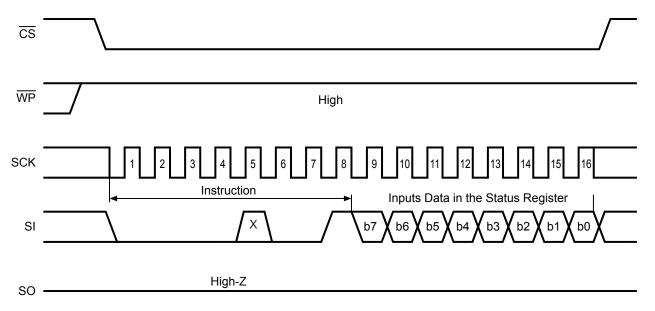
Before inputting the WRSR instruction, set bit WEL by the WREN instruction. The operation of WRSR is shown below.

Set the chip select  $(\overline{CS})$  "L" first. After that, input the instruction code and data from serial data input (SI). To start WRSR write  $(t_{PR})$ , set the chip select  $(\overline{CS})$  to "H" after inputting data or before inputting a rising of the next serial clock. It is possible to confirm the operation status by reading the value of bit WIP during WRSR write. Bit WIP is "1" during write, "0" during any other status. Bit WEL is reset when write is completed.

With the WRSR instruction, the values of BP1 and BP0; which determine the area size the users can handle as the read only memory; can be changed. When  $\overline{\text{WP}}$  pin is "L", however, the WRSR instruction is not be performed (Refer to "**Protect Operation**").

Bits BP1 and BP0 keep the value which is the one prior to the WRSR instruction during the WRSR instruction. The newly updated value is changed when the WRSR instruction has completed.

To cancel the WRSR instruction, input the clock different from a specified value (n = 16 clock) while  $\overline{CS}$  is in "L".



Remark X = Don't care.

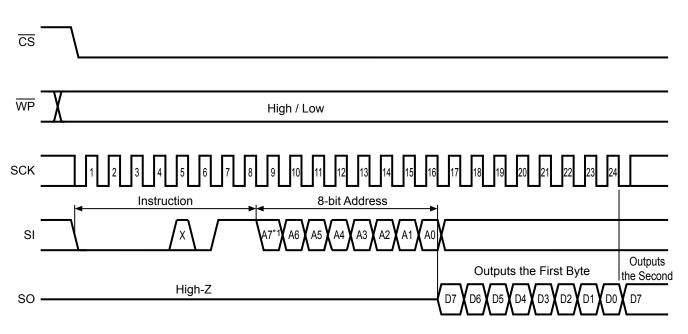
Figure 15 WRSR Operation

#### 6. Read memory data (READ)

The READ operation is shown below. Input the instruction code and the address from serial data input (SI) after inputting "L" to the chip select ( $\overline{CS}$ ). The input address is loaded to the internal address counter, and data in the address is output from the serial data output (SO).

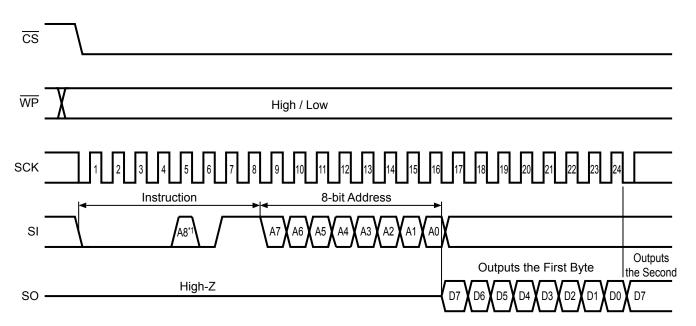
Next, by inputting the serial clock (SCK) keeping the chip select ( $\overline{\text{CS}}$ ) in "L", the address is automatically incremented so that data in the following address is sequentially output. The address counter rolls over to the first address by increment in the last address.

To finish the read cycle, set CS to "H". It is possible to raise the chip select always during the cycle. During write, the READ instruction code is not be accepted or operated.



\*1 In the S-25A010A, A7 = Don't care because the address range is A6 to A0.

Figure 16 READ Operation (S-25A010A/020A)



<sup>\*1</sup> In the S-25A040A, assign bit A8 in the address into the fifth bit in an instruction code.

Figure 17 READ Operation (S-25A040A)

# 7. Write memory data (WRITE)

Figure 18 and Figure 19 show the timing chart when inputting 1-byte data. Input the instruction code, the address and data from serial data input (SI) after inputting "L" to the chip select ( $\overline{CS}$ ). To start WRITE ( $t_{PR}$ ), set the chip select ( $\overline{CS}$ ) to "H" after inputting data or before inputting a rising of the next serial clock. Bit WIP and WEL are reset to "0" when write has completed.

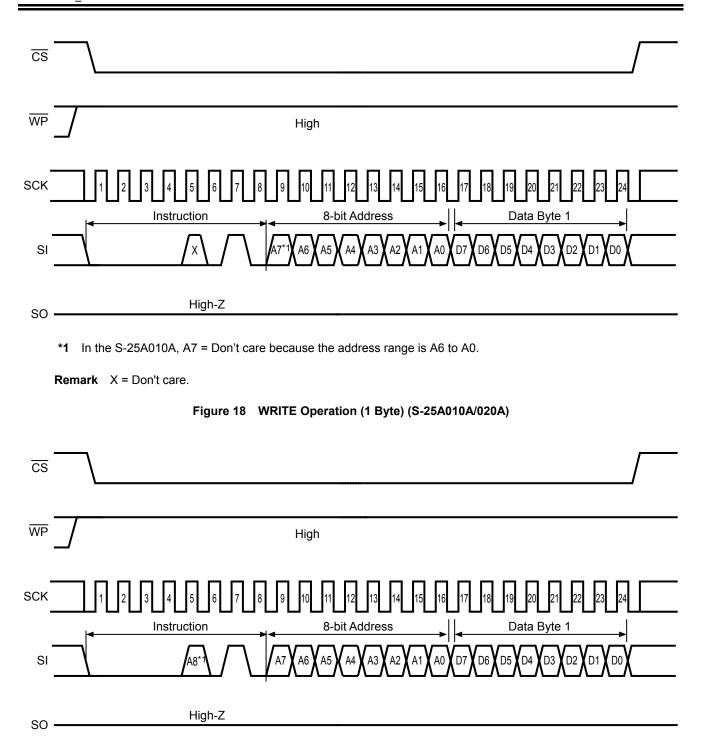
This IC can Page write of 16 bytes. Its function to transmit data is as same as Byte write basically, but it operates Page write by receiving sequential 8-bit write data as much data as page size has. Input the instruction code, the address and data from serial data input (SI) after inputting "L" in  $\overline{CS}$ , as the WRITE operation (page) shown in **Figure 20** and **Figure 21**. Input the next data while keeping  $\overline{CS}$  in "L". After that, repeat inputting data of 8-bit sequentially. At the end, by setting  $\overline{CS}$  to "H", the WRITE operation starts (t<sub>PR</sub>).

4 of the lower bits in the address are automatically incremented every time when receiving write data of 8-bit. Thus, even if write data exceeds 16 bytes, the higher bits in the address do not change. And 4 of lower bits in the address roll over so that write data which is previously input is overwritten.

These are cases when the WRITE instruction is not accepted or operated.

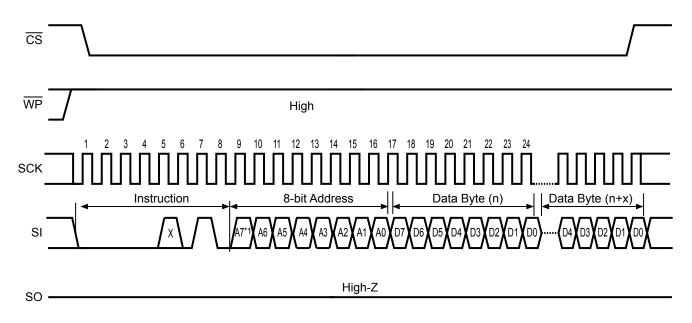
- Bit WEL is not set to "1" (not set to "1" beforehand immediately before the WRITE instruction)
- · During WRITE operation
- The address to be written is in the protect area by BP1 and BP0
- WP pin is set to "L"

To cancel the WRITE instruction, input the clock different from a specified value (n = 16 + m  $\times$  8 clock) while  $\overline{CS}$  is in "L".



\*1 In the S-25A040A, assign bit A8 in the address into the fifth bit in an instruction code.

Figure 19 WRITE Operation (1 Byte) (S-25A040A)

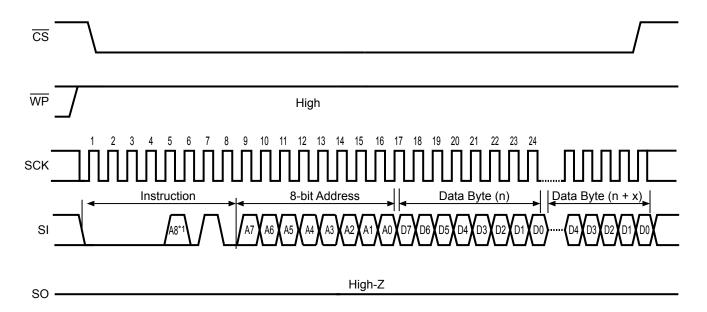


\*1 In the S-25A010A, A7 = Don't care because the address range is A6 to A0.

**Remark** X = Don't care.

22

Figure 20 WRITE Operation (Page) (S-25A010A/020A)



\*1 In the S-25A040A, assign bit A8 in the address into the fifth bit in an instruction code.

Figure 21 WRITE Operation (Page) (S-25A040A)

ABLIC Inc.

# Protect Operation

**Table 21** shows the block settings of write protect. Setting value in Protect Bits (BP1, BP0) in the status register protect data in the area of all / 50% / 25% of the memory address.

Setting WP pin to "L" provides the following settings.

- Write protect for the WRITE. WRSR instructions
- · Reset bit WEL

The timing during the cycle write to the status register is showed in "Figure 8 Valid Timing in Write Protect" and "Figure 9 Invalid Timing in Write Protect".

Status I	Status Register		Address of Write Protect Block				
BP1	BP0	Area of Write Protect	S-25A010A	S-25A020A	S-25A040A		
0	0	0%	None	None	None		
0	1	25%	60h to 7Fh	C0h to FFh	180h to 1FFh		
1	0	50%	40h to 7Fh	80h to FFh	100h to 1FFh		
1	1	100%	00h to 7Fh	00h to FFh	000h to 1FFh		

Table 21 Block Settings of Write Protect

# ■ Hold Operation

The hold operation is used to pause serial communications without setting this IC in the non-select status. In the hold status, the serial data output goes in "High-Z", and both of the serial data input and the serial clock go in "Don't care". Be sure to set the chip select ( $\overline{CS}$ ) to "L" to set this IC in the select status during the hold status.

Generally, during the hold status, this IC holds the select status. But if setting this IC in the non-select status, the users can finish the operation even in progress. **Figure 22** shows the hold operation.

These are two statuses when the serial clock (SCK) is set to "L".

- If setting hold (HOLD) to "L", hold (HOLD) is switched at the same time the hold status starts.
- If setting hold (HOLD) to "H", hold (HOLD) is switched at the same time the hold status ends.

These are two statuses when the serial clock (SCK) is set to "H".

- If setting hold (HOLD) to "L", the hold status starts when the serial clock goes in "L" after hold (HOLD) is switched.
- If setting hold (HOLD) to "H", the hold status ends when the serial clock goes in "L" after hold (HOLD) is switched.

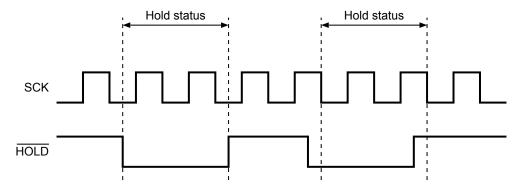


Figure 22 Hold Operation

# ■ Write Protect Function during the Low Power Supply Voltage

This IC has a built-in detection circuit which operates with the low power supply voltage. This IC cancels the write operation (WRITE, WRSR) when the power supply voltage drops and power-on, at the same time, goes in the write protect status (WRDI) automatically to reset bit WEL. The detection voltage is 1.20 V typ., the release voltage is 1.35 V typ., and its hysteresis is approx. 0.15 V (Refer to **Figure 23**).

To operate write, after the power supply voltage dropped once but rose to the voltage level which allows write again, be sure to set the Write Enable Latch bit (WEL) before operating write (WRITE, WRSR).

In the write operation, data in the address written during the low power supply voltage is not assured.

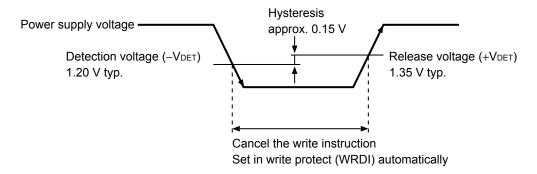


Figure 23 Operation during the Low Power Supply Voltage

# ■ Input Pin and Output Pin

#### 1. Connection of input pin

All input pins in this IC have the CMOS structure. Do not set these pins in "High-Z" during operation when you design. Especially, set the  $\overline{\text{CS}}$  input pin in the non-select status "H" during power-on/off and standby. The error write does not occur as long as the  $\overline{\text{CS}}$  pin is in the non-select status "H". Set the  $\overline{\text{CS}}$  pin to  $V_{\text{CC}}$  via a resistor (the pull-up resistor of 10 k $\Omega$  to 100 k $\Omega$ ).

If the CS pin and the SCK pin change from "L" to "H" simultaneously, data may be input from the SI pin.

To prevent the error for sure, it is recommended to pull down the SCK pin to GND. In addition, it is recommended to pull up the SI pin, the  $\overline{\text{WP}}$  pin and the  $\overline{\text{HOLD}}$  pin to  $V_{CC}$ , or pull down these pins to GND, respectively. Connecting the  $\overline{\text{WP}}$  pin and the  $\overline{\text{HOLD}}$  pin to  $V_{CC}$  directly is also possible when these pins are not in use.

## 2. Equivalent circuit of input pin and output pin

**Figure 24** and **Figure 25** show the equivalent circuits of input pins in this IC. A pull-up and pull-down elements are not included in each input pin, pay attention not to set it in the floating state when you design.

Figure 26 shows the equivalent circuit of the output pin. This pin has the tri-state output of "H" / "L" / "High-Z".

## 2. 1 Input pin

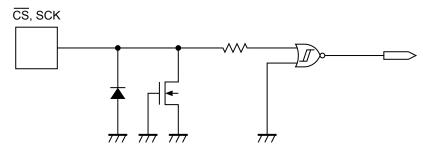


Figure 24 CS, SCK Pin

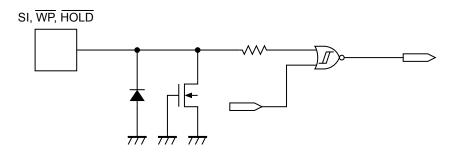


Figure 25 SI, WP, HOLD Pin

## 2. 2 Output pin

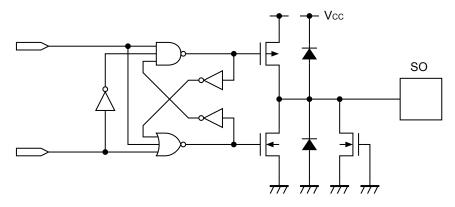
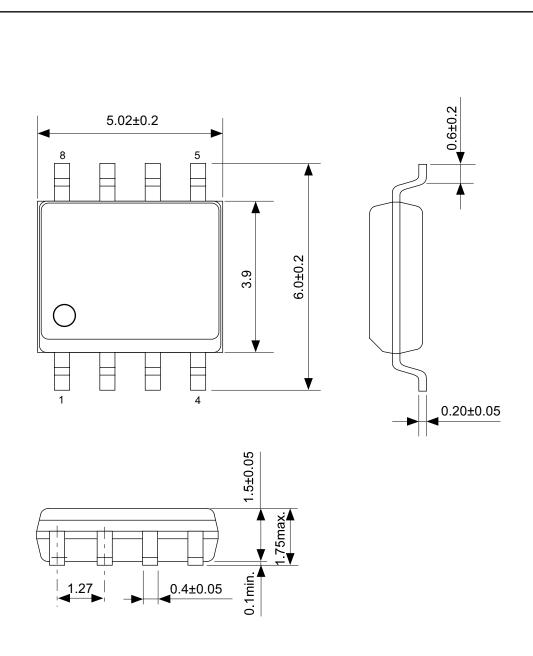


Figure 26 SO Pin

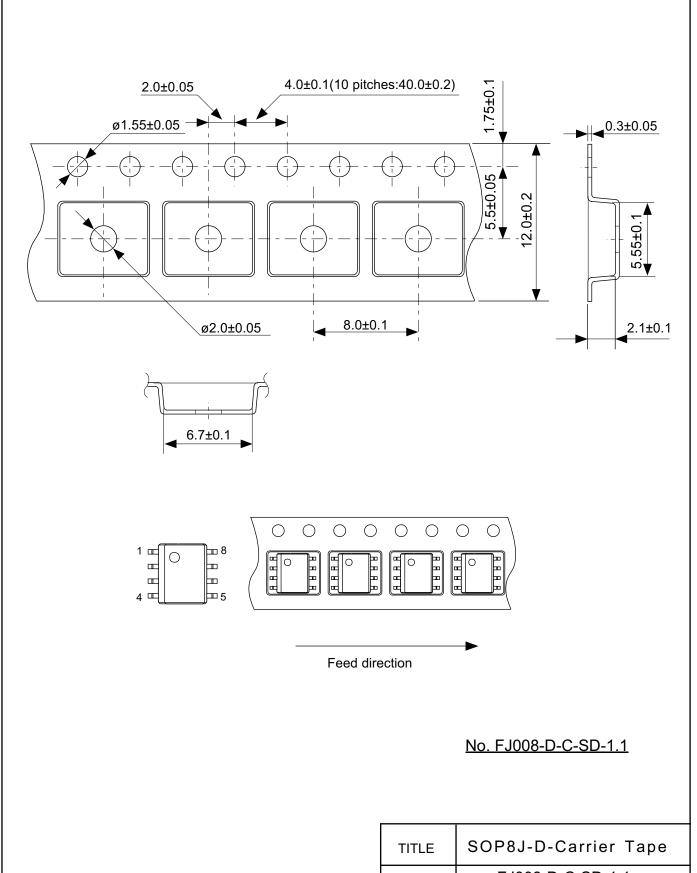
## ■ Precautions

- Absolute maximum ratings: Do not operate these ICs in excess of the absolute maximum ratings (as listed on the
  data sheet). Exceeding the supply voltage rating can cause latch-up. Perform operations after confirming the detailed
  operation condition in the data sheet.
- Operations with moisture on this IC's pins may occur malfunction by short-circuit between pins. Especially, in occasions like picking this IC up from low temperature tank during the evaluation. Be sure that not remain frost on this IC's pins to prevent malfunction by short-circuit.
  - Also attention should be paid in using on environment, which is easy to dew for the same reason.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- ABLIC Inc. claims no responsibility for any and all disputes arising out of or in connection with any infringement of the products including this IC upon patents owned by a third party.

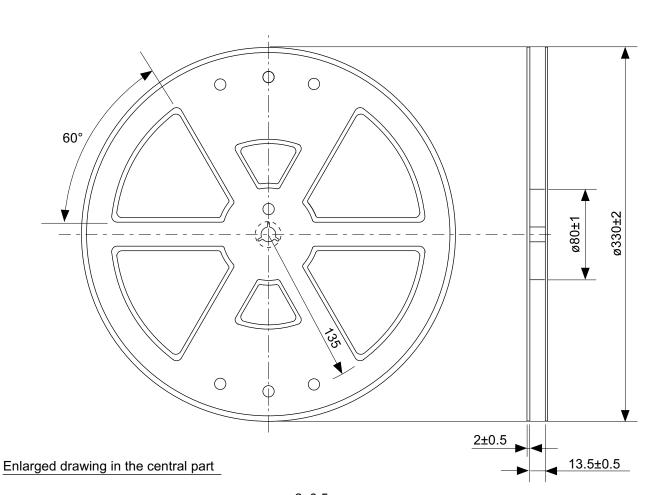


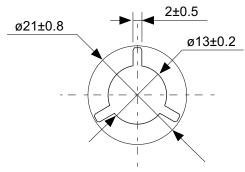
# No. FJ008-A-P-SD-2.2

TITLE	SOP8J-D-PKG Dimensions				
No.	FJ008-A-P-SD-2.2				
ANGLE	<b>\$ = 1</b>				
UNIT	mm				
ABLIC Inc.					



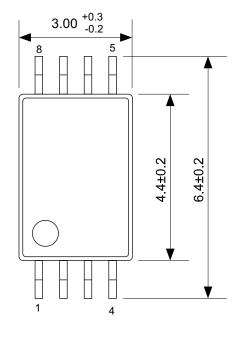
TITLE	SOP8J-D-Carrier Tape				
No.	FJ008-D-C-SD-1.1				
ANGLE					
UNIT	mm				
ABLIC Inc.					

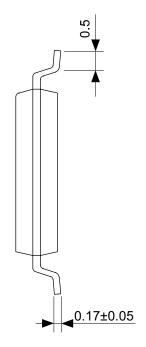


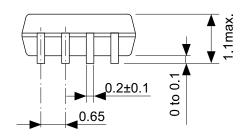


# No. FJ008-D-R-SD-1.1

TITLE	SOP8J-D-Reel					
No.		FJ008	-D-R-SD-	1.1		
ANGLE			QTY.	2,000		
UNIT	mm					
ABLIC Inc.						

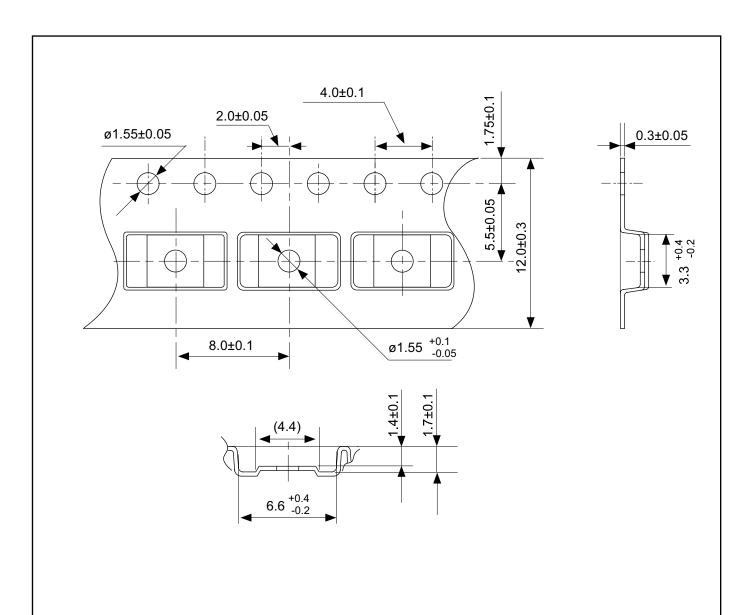


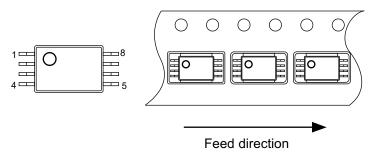




# No. FT008-A-P-SD-1.2

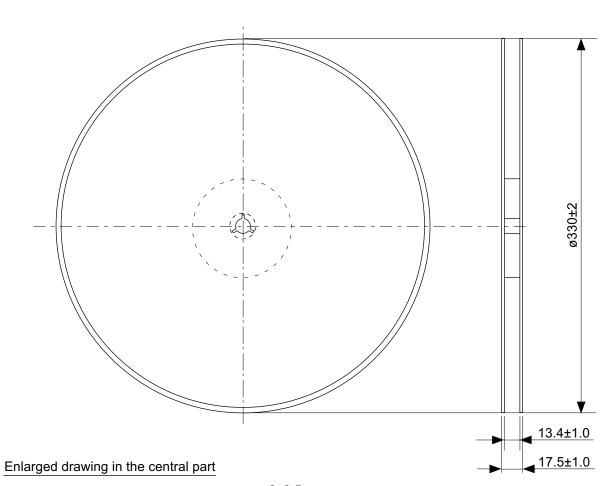
TITLE	TSSOP8-E-PKG Dimensions	
No.	FT008-A-P-SD-1.2	
ANGLE	<b>\$</b> \displaystart	
UNIT	mm	
ABLIC Inc.		

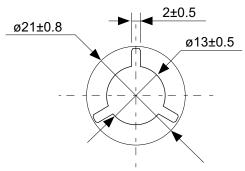




# No. FT008-E-C-SD-1.0

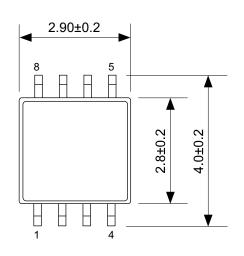
TITLE	TSSOP8-E-Carrier Tape	
No.	FT008-E-C-SD-1.0	
ANGLE		
UNIT	mm	
ABLIC Inc.		

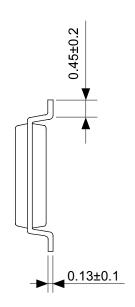


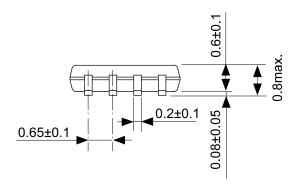


# No. FT008-E-R-SD-1.0

TITLE	TSSOP8-E-Reel			
No.	FT008-E-R-SD-1.0			
ANGLE		QTY.	3,000	
UNIT	mm			
ABLIC Inc.				

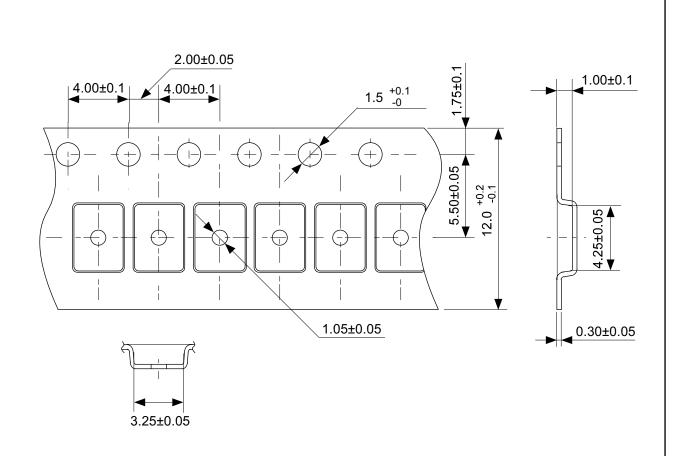


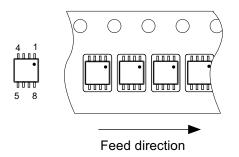




# No. FM008-A-P-SD-1.2

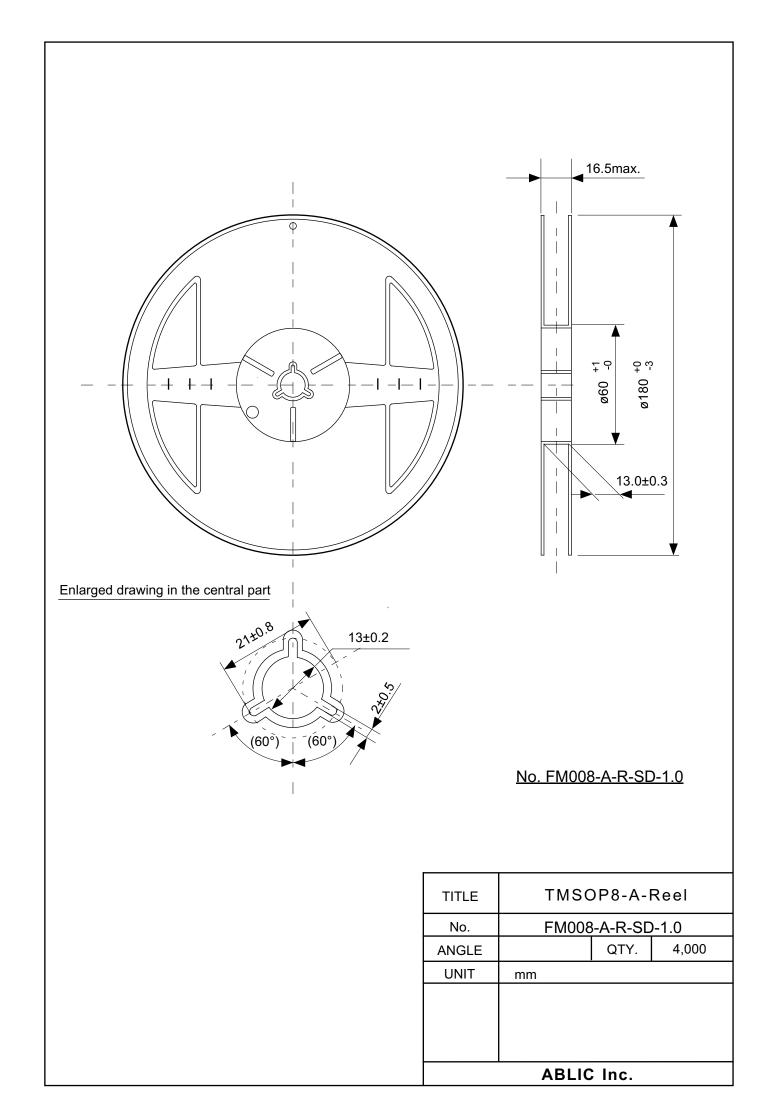
TITLE	TMSOP8-A-PKG Dimensions	
No.	FM008-A-P-SD-1.2	
ANGLE	<b>Q</b>	
UNIT	mm	
ABLIC Inc.		





# No. FM008-A-C-SD-2.0

TITLE	TMSOP8-A-Carrier Tape	
No.	FM008-A-C-SD-2.0	
ANGLE		
UNIT	mm	
ABLIC Inc.		



# **Disclaimers (Handling Precautions)**

- 1. All the information described herein (product data, specifications, figures, tables, programs, algorithms and application circuit examples, etc.) is current as of publishing date of this document and is subject to change without notice.
- 2. The circuit examples and the usages described herein are for reference only, and do not guarantee the success of any specific mass-production design.
  - ABLIC Inc. is not responsible for damages caused by the reasons other than the products described herein (hereinafter "the products") or infringement of third-party intellectual property right and any other right due to the use of the information described herein.
- 3. ABLIC Inc. is not responsible for damages caused by the incorrect information described herein.
- 4. Be careful to use the products within their specified ranges. Pay special attention to the absolute maximum ratings, operation voltage range and electrical characteristics, etc.
  - ABLIC Inc. is not responsible for damages caused by failures and / or accidents, etc. that occur due to the use of the products outside their specified ranges.
- 5. When using the products, confirm their applications, and the laws and regulations of the region or country where they are used and verify suitability, safety and other factors for the intended use.
- 6. When exporting the products, comply with the Foreign Exchange and Foreign Trade Act and all other export-related laws, and follow the required procedures.
- 7. The products must not be used or provided (exported) for the purposes of the development of weapons of mass destruction or military use. ABLIC Inc. is not responsible for any provision (export) to those whose purpose is to develop, manufacture, use or store nuclear, biological or chemical weapons, missiles, or other military use.
- 8. The products are not designed to be used as part of any device or equipment that may affect the human body, human life, or assets (such as medical equipment, disaster prevention systems, security systems, combustion control systems, infrastructure control systems, vehicle equipment, traffic systems, in-vehicle equipment, aviation equipment, aerospace equipment, and nuclear-related equipment), excluding when specified for in-vehicle use or other uses. Do not apply the products to the above listed devices and equipments without prior written permission by ABLIC Inc. Especially, the products cannot be used for life support devices, devices implanted in the human body and devices that directly affect human life, etc.
  - Prior consultation with our sales office is required when considering the above uses.
  - ABLIC Inc. is not responsible for damages caused by unauthorized or unspecified use of our products.
- 9. Semiconductor products may fail or malfunction with some probability.
  - The user of the products should therefore take responsibility to give thorough consideration to safety design including redundancy, fire spread prevention measures, and malfunction prevention to prevent accidents causing injury or death, fires and social damage, etc. that may ensue from the products' failure or malfunction.
  - The entire system must be sufficiently evaluated and applied on customer's own responsibility.
- 10. The products are not designed to be radiation-proof. The necessary radiation measures should be taken in the product design by the customer depending on the intended use.
- 11. The products do not affect human health under normal use. However, they contain chemical substances and heavy metals and should therefore not be put in the mouth. The fracture surfaces of wafers and chips may be sharp. Be careful when handling these with the bare hands to prevent injuries, etc.
- 12. When disposing of the products, comply with the laws and ordinances of the country or region where they are used.
- 13. The information described herein contains copyright information and know-how of ABLIC Inc.

  The information described herein does not convey any license under any intellectual property rights or any other rights belonging to ABLIC Inc. or a third party. Reproduction or copying of the information from this document or any part of this document described herein for the purpose of disclosing it to a third-party without the express permission of ABLIC Inc. is strictly prohibited.
- 14. For more details on the information described herein, contact our sales office.

2.0-2018.01

